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Terms	Documents
L4 and (low temperature or room temperature)	19

Database:

Search:

Search History**DATE: Tuesday, July 09, 2002** [Printable Copy](#) [Create Case](#)Set Name Query
side by sideHit Count Set Name
result set*DB=USPT; PLUR=YES; OP=ADJ*

<u>L5</u>	L4 and (low temperature or room temperature)	19	<u>L5</u>
<u>L4</u>	L3 and (e-beam or e beam or electron beam)	21	<u>L4</u>
<u>L3</u>	L1 and (epoxy with acrylate)	56	<u>L3</u>
<u>L2</u>	L1 and cold\$1seal	0	<u>L2</u>
<u>L1</u>	428/36.6 or 428/36.7 or 428/36.91	2202	<u>L1</u>

END OF SEARCH HISTORY

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Terms	Documents
L2 and (electron beam or e\$1beam)	2

Database:

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result set

DB=USPT; PLUR=YES; OP=ADJ

<u>L3</u>	L2 and (electron beam or e\$1beam)	2	<u>L3</u>
<u>L2</u>	L1 and cold seal	266	<u>L2</u>
	428/36.8 or 428/343 or 428/355BL or 428/355EP or 428/356 or		
<u>L1</u>	428/413 or 428/492 or 428/493 or 428/495 or 428/517 or 206/\$10 or 426/\$10	143177	<u>L1</u>

END OF SEARCH HISTORY